

<b>Notice of References Cited</b>			Application/Control No.	Applicant(s)/Patent Under Reexamination REESE ET AL.	
			Examiner Houshang Safaipour	Art Unit 2625	Page 1 of 1

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*	B	US-2003/0048484	03-2003	Seki et al.	358/402
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